BTA208B-1000C

Three-quadrant triacs high commutation Rev. 01 — 5 December 2005

Product data sheet

Product profile 1.

1.1 General description

Passivated high voltage, high commutation triac in a SOT404 surface mounted device, plastic package. This triac is intended for use in motor control circuits where high blocking voltage, high static and dynamic dV/dt as well as high dl/dt can occur. This device will commutate the full rated RMS current at the maximum rated junction temperature without the aid of a snubber.

1.2 Features

■ False trigger immunity

■ 1000 V, V_{DRM} guaranteed

1.3 Applications

Motor control

Reversible induction motors

1.4 Quick reference data

■ $I_{TSM} \le 65 \text{ A}$

 $V_{DRM} \le 1000 \text{ V}$

 $I_{T(RMS)} \le 8 A$

 $I_{GT} \le 35 \text{ mA}$

Pinning information 2.

Table 1: **Pinning**

| Pin | Description | Simplified outline | Symbol |
|-----|--------------------------------|--------------------|--------|
| 1 | main terminal 1 (T1) | | |
| 2 | main terminal 2 (T2) | mb | T2—T1 |
| 3 | gate (G) | | sym051 |
| mb | mounting base; main terminal 2 | | |
| | | SOT404 (D2PAK) | |
| | | | |







3. Ordering information

Table 2: Ordering information

| Type number | Package | | | | |
|---------------|---------|--|---------|--|--|
| | Name | Description | Version | | |
| BTA208B-1000C | D2PAK | plastic single-ended surface mounted package; 3 leads (one lead cropped) | SOT404 | | |

4. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit | |
|---------------------|--------------------------------------|--|-----|------|------------------|--|
| V_{DRM} | repetitive peak off-state voltage | | - | 1000 | V | |
| I _{T(RMS)} | RMS on-state current | full sine wave; T _{mb} ≤ 102 °C; see <u>Figure 4</u> and <u>5</u> | - | 8 | Α | |
| I _{TSM} | non-repetitive peak on-state current | full sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3 | | | | |
| | | t = 20 ms | - | 65 | Α | |
| | | t = 16.7 ms | - | 71 | Α | |
| l ² t | I ² t for fusing | t = 10 ms | - | 21 | A ² s | |
| dl _T /dt | rate of rise of on-state current | $I_{TM} = 12 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$ | - | 100 | A/μs | |
| I _{GM} | peak gate current | | - | 2 | Α | |
| P _{GM} | peak gate power | | - | 5 | W | |
| P _{G(AV)} | average gate power | over any 20 ms period | - | 0.5 | W | |
| T _{stg} | storage temperature | | -40 | +150 | °C | |
| T _i | junction temperature | | - | 125 | °C | |

 α = conduction angle

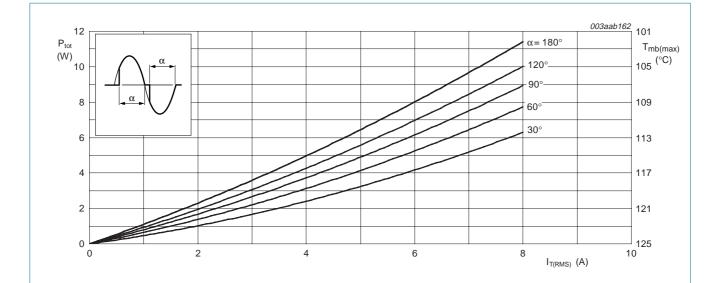


Fig 1. Total power dissipation as a function of RMS on-state current; maximum values

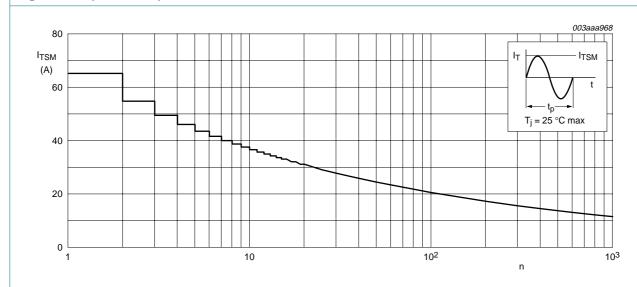


Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

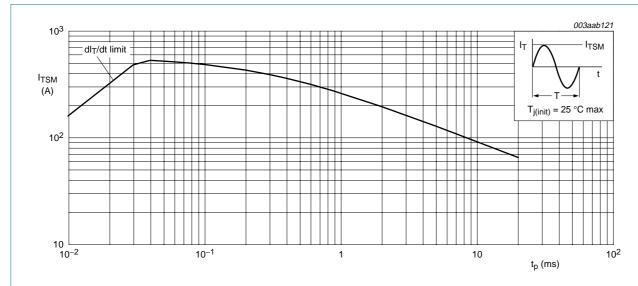


Fig 3. Non-repetitive peak on-state current as a function of pulse duration; maximum values

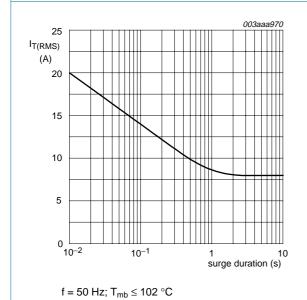


Fig 4. RMS on-state current as a function of surge duration; maximum values

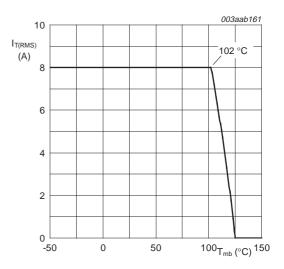


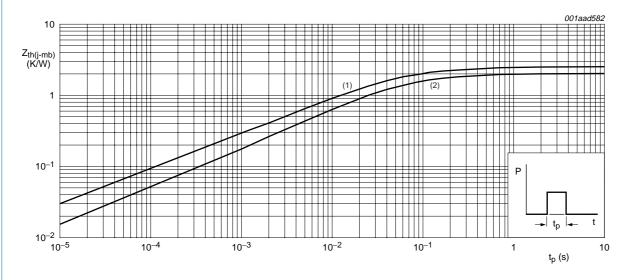
Fig 5. RMS on-state current as a function of mounting base temperature; maximum values



5. Thermal characteristics

Table 4: Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|---|--------------------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | full cycle; see Figure 6 | - | - | 2 | K/W |
| | | half cycle; see Figure 6 | - | - | 2.4 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | minimum footprint | - | 55 | - | K/W |



- (1) Unidirectional
- (2) Bidirectional

Fig 6. Transient thermal impedance from junction to mounting base as a function of pulse duration



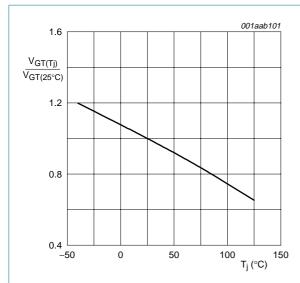


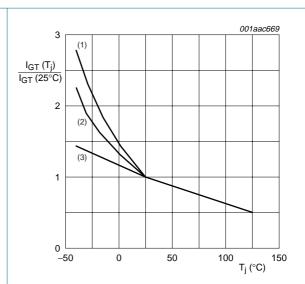
Table 5: Characteristics

 $T_i = 25 \,^{\circ}C$ unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | |
|-----------------------|---------------------------------------|---|------|------|------|------|--|
| Static char | acteristics | | | | | | |
| I _{GT} | gate trigger current | V _D = 12 V; I _T = 0.1 A; see <u>Figure 8</u> [1] | | | | | |
| | | T2+ G+ | 2 | 6 | 35 | mA | |
| | | T2+ G- | 2 | 13 | 35 | mA | |
| | | T2- G- | 2 | 23 | 35 | mA | |
| IL | latching current | $V_D = 12 \text{ V; } I_{GT} = 0.1 \text{ A; see}$ Figure 10 | | | | | |
| | | T2+ G+ | - | 25 | 50 | mA | |
| | | T2+ G- | - | 48 | 75 | mA | |
| | | T2- G- | - | 30 | 50 | mA | |
| I _H | holding current | $V_D = 12 \text{ V; } I_{GT} = 0.1 \text{ A; see}$ Figure 11 | - | 20 | 50 | mA | |
| V _T | on-state voltage | I _T = 10 A; see <u>Figure 9</u> | - | 1.3 | 1.65 | V | |
| V _{GT} | gate trigger voltage | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; see } \frac{\text{Figure 7}}{}$ | - | 0.7 | 1.5 | V | |
| | | $V_D = 400 \text{ V}; I_T = 0.1 \text{ A}; T_j = 125 ^{\circ}\text{C}$ | 0.25 | 0.4 | - | V | |
| I _D | off-state current | $V_D = V_{DRM(max)}$; $T_j = 125 ^{\circ}C$ | - | 0.1 | 0.5 | mA | |
| Dynamic c | haracteristics | | | | | | |
| dV _D /dt | rate of rise of off-state voltage | $V_{DM} = 67 \% V_{DRM(max)};$ $T_j = 125 ^{\circ}C;$ exponential waveform; gate open circuit | 1000 | 4000 | - | V/µs | |
| dl _{com} /dt | rate of change of commutating current | $V_{DM} = 400 \text{ V}; T_j = 125 ^{\circ}\text{C};$ $I_{T(RMS)} = 8 \text{ A};$ without snubber; gate open circuit; see Figure 12 | 12 | 32 | - | A/ms | |
| t _{gt} | gate-controlled turn-on time | $I_{TM} = 12 \text{ A}; V_D = V_{DRM(max)};$ $I_G = 0.1 \text{ A}; dI_G/dt = 5 \text{ A}/\mu\text{s}$ | - | 2 | - | μs | |

^[1] Device will not trigger in the T2- G+ quadrant.

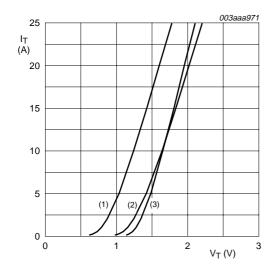




- (1) T2-G-
- (2) T2+ G-
- (3) T2+ G+

Fig 7. Normalized gate trigger voltage as a function of junction temperature







- (1) $T_i = 125 \,^{\circ}C$; typical values
- (2) $T_i = 125 \,^{\circ}C$; maximum values
- (3) $T_i = 25 \,^{\circ}C$; maximum values

Fig 9. On-state current as a function of on-state voltage

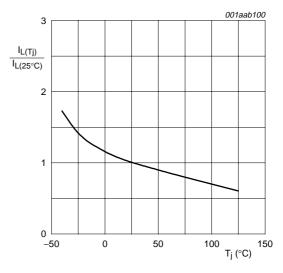


Fig 10. Normalized latching current as a function of junction temperature

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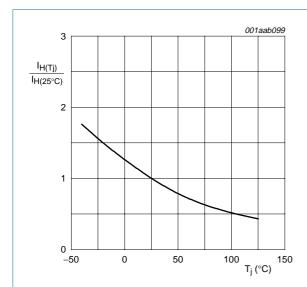


Fig 11. Normalized holding current as a function of junction temperature

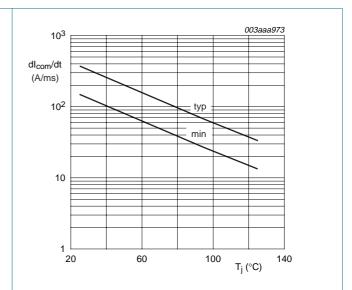


Fig 12. Rate of change of commutating current as a function of junction temperature; typical and minimum values



7. Package outline

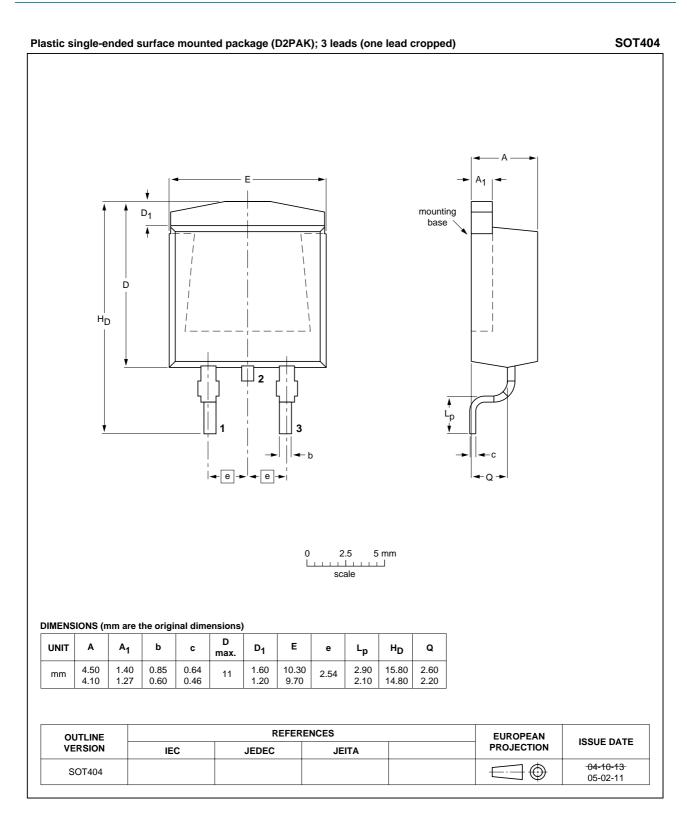


Fig 13. Package outline SOT404 (D2PAK)

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8. Revision history

Table 6: Revision history

| Document ID | Release date | Data sheet status | Change notice | Doc. number | Supersedes |
|-----------------|--------------|--------------------|---------------|-------------|------------|
| BTA208B-1000C_1 | 20051205 | Product data sheet | - | - | - |



9. Data sheet status

| Level | Data sheet status [1] | Product status [2] [3] | Definition |
|-------|-----------------------|------------------------|--|
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Product data sheet

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